Application/Control No. Applicant(s)/Patent Under Reexamination 09/731,706 NAKANO, TOSHIAKI Notice of References Cited Examiner Art Unit Page 1 of 1 Sam Rimell 2164 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY 705/14 US-6,026,371 02-2000 Beck et al. Α US-В US-С US-D US-Ε US-F US-G US-USı US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Country Code-Number-Kind Code Name MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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